

TOSHIBA Power MOS FET Module Silicon N Channel MOS Type (Four L²-π-MOSV in One)

MP4411

High Power, High Speed Switching Applications
For Printer Head Pin Driver and Pulse Motor Driver
For Solenoid Driver

- 4-V gate drivability
- Small package by full molding (SIP 12 pin)
- High drain power dissipation (4-device operation)
: $P_T = 28 \text{ W}$ ($T_c = 25^\circ\text{C}$)
- Low drain-source ON resistance: $R_{DS(ON)} = 0.28 \Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 3.5 \text{ S}$ (typ.)
- Low leakage current: $I_{GSS} = \pm 10 \mu\text{A}$ (max) ($V_{GS} = \pm 16 \text{ V}$)
 $I_{DSS} = 100 \mu\text{A}$ (max) ($V_{DS} = 100 \text{ V}$)
- Enhancement mode: $V_{th} = 0.8 \text{ to } 2.0 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$)

Maximum Ratings ($T_a = 25^\circ\text{C}$)

| Characteristics | | Symbol | Rating | Unit |
|--|--------------------------|-----------|------------|------------------|
| Drain-source voltage | | V_{DSS} | 100 | V |
| Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$) | | V_{DGR} | 100 | V |
| Gate-source voltage | | V_{GSS} | ± 20 | V |
| Drain current | DC | I_D | 3 | A |
| | Pulse | I_{DP} | 12 | |
| Drain power dissipation (1-device operation, $T_a = 25^\circ\text{C}$) | | P_D | 2.2 | W |
| Drain power dissipation (4-device operation) | $T_a = 25^\circ\text{C}$ | P_{DT} | 4.4 | W |
| | $T_c = 25^\circ\text{C}$ | | 28 | |
| Single pulse avalanche energy (Note 1) | | E_{AS} | 140 | mJ |
| Avalanche current | | I_{AR} | 3 | A |
| Repetitive avalanche energy (Note 2) | 1 device operation | E_{AR} | 0.22 | mJ |
| | 4 devices operation | E_{ART} | 0.44 | |
| Channel temperature | | T_{ch} | 150 | $^\circ\text{C}$ |
| Storage temperature range | | T_{stg} | -55 to 150 | $^\circ\text{C}$ |

Note 1: Condition for avalanche energy (single pulse) measurement

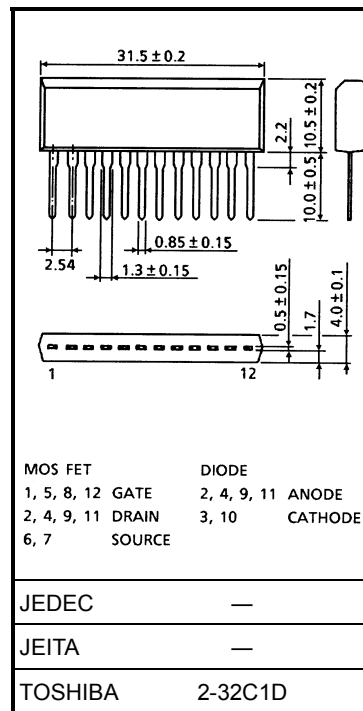
 $V_{DD} = 50 \text{ V}$, starting $T_{ch} = 25^\circ\text{C}$, $L = 20 \text{ mH}$, $R_G = 25 \Omega$, $I_{AR} = 3 \text{ A}$

Note 2: Repetitive rating; pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

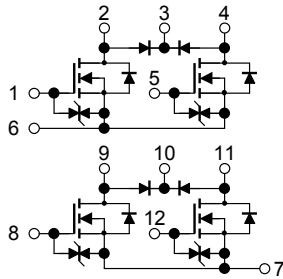
Industrial Applications

Unit: mm



Weight: 3.9 g (typ.)

Array Configuration

Thermal Characteristics

| Characteristics | Symbol | Max | Unit |
|---|-----------------------|------|--------------------|
| Thermal resistance from channel to ambient (4-device operation, $T_a = 25^\circ\text{C}$) | $\Sigma R_{th(ch-a)}$ | 28.4 | $^\circ\text{C/W}$ |
| Thermal resistance from channel to case (4-device operation, $T_c = 25^\circ\text{C}$) | $\Sigma R_{th(ch-c)}$ | 4.46 | $^\circ\text{C/W}$ |
| Maximum lead temperature for soldering purposes (3.2 mm from case for $t = 10$ s) | T_L | 260 | $^\circ\text{C}$ |

Electrical Characteristics ($T_a = 25^\circ\text{C}$)

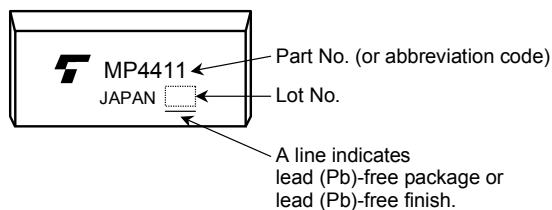
| Characteristics | | Symbol | Test Condition | Min | Typ. | Max | Unit |
|--|---------------|---------------|--|-----|------|----------|---------------|
| Gate leakage current | | I_{GSS} | $V_{GS} = \pm 16\text{ V}$, $V_{DS} = 0\text{ V}$ | — | — | ± 10 | μA |
| Drain cut-off current | | I_{DSS} | $V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$ | — | — | 100 | μA |
| Drain-source breakdown voltage | | $V_{(BR)DSS}$ | $I_D = 10\text{ mA}$, $V_{GS} = 0\text{ V}$ | 100 | — | — | V |
| Gate threshold voltage | | V_{th} | $V_{DS} = 10\text{ V}$, $I_D = 1\text{ mA}$ | 0.8 | — | 2.0 | V |
| Drain-source ON resistance | | $R_{DS(on)}$ | $V_{GS} = 4\text{ V}$, $I_D = 2\text{ A}$ | — | 0.36 | 0.45 | Ω |
| | | | $V_{GS} = 10\text{ V}$, $I_D = 2\text{ A}$ | — | 0.28 | 0.35 | |
| Forward transfer admittance | | $ Y_{fs} $ | $V_{DS} = 10\text{ V}$, $I_D = 2\text{ A}$ | 1.5 | 3.5 | — | S |
| Input capacitance | | C_{iss} | $V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$ | — | 280 | — | pF |
| Reverse transfer capacitance | | C_{rss} | | — | 50 | — | pF |
| Output capacitance | | C_{oss} | | — | 105 | — | pF |
| Switching time | Rise time | t_r | <p>V_{IN}: $t_r, t_f < 5\text{ ns}$, duty $\leq 1\%$, $t_w = 10\text{ }\mu\text{s}$</p> | — | 20 | — | ns |
| | Turn-on time | t_{on} | | — | 50 | — | |
| | Fall time | t_f | | — | 40 | — | |
| | Turn-off time | t_{off} | | — | 170 | — | |
| Total gate charge (gate-source plus gate-drain) | | Q_g | $V_{DD} \approx 80\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 3\text{ A}$ | — | 13.5 | — | nC |
| Gate-source charge | | Q_{gs} | | — | 8.5 | — | nC |
| Gate-drain ("miller") charge | | Q_{gd} | | — | 5 | — | nC |

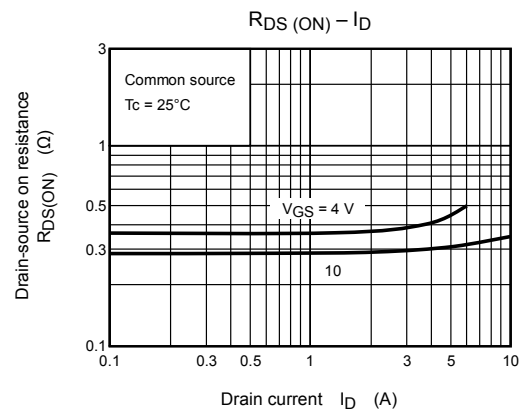
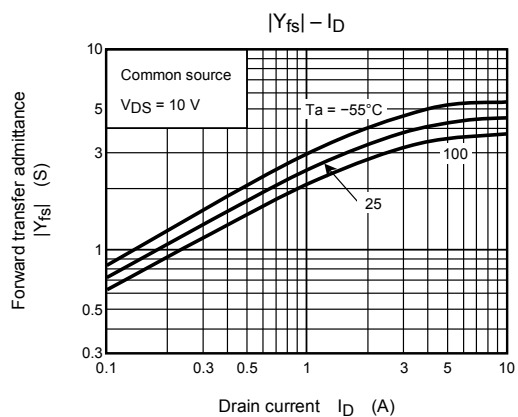
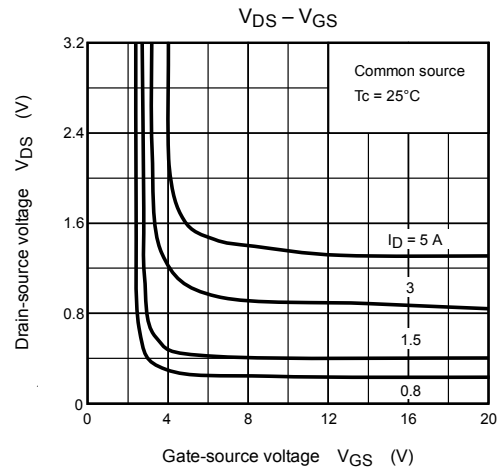
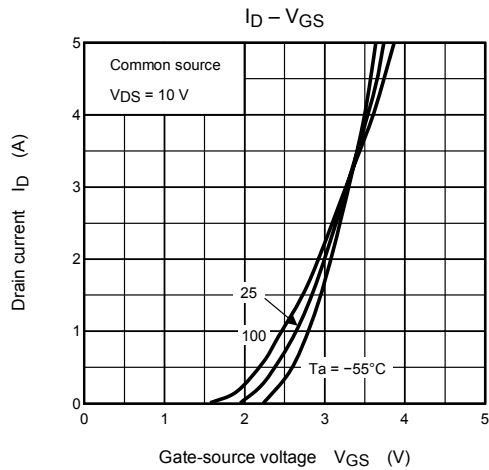
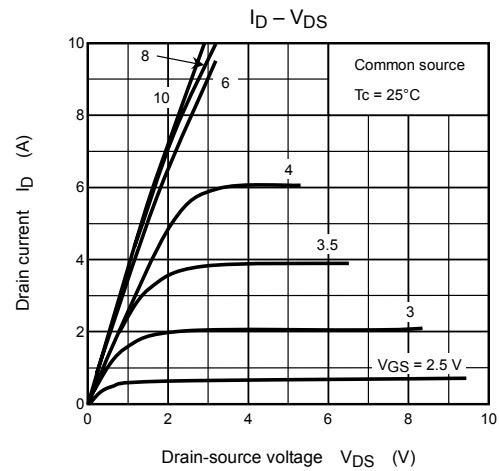
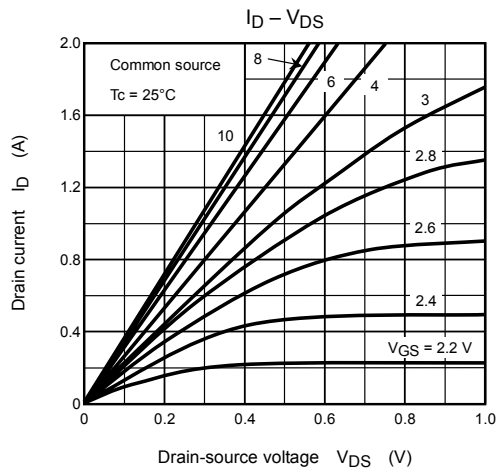
Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

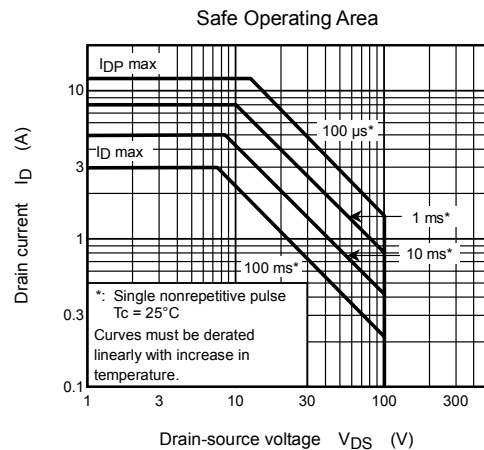
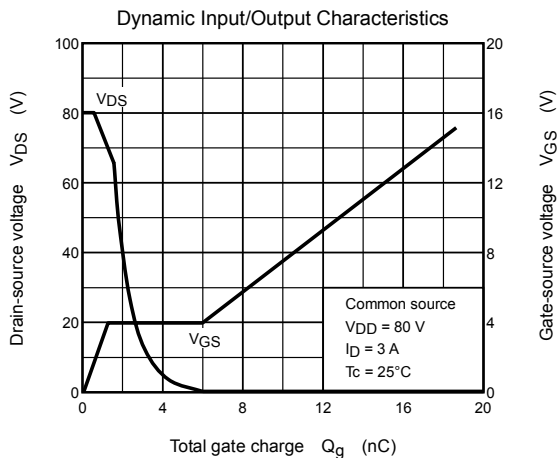
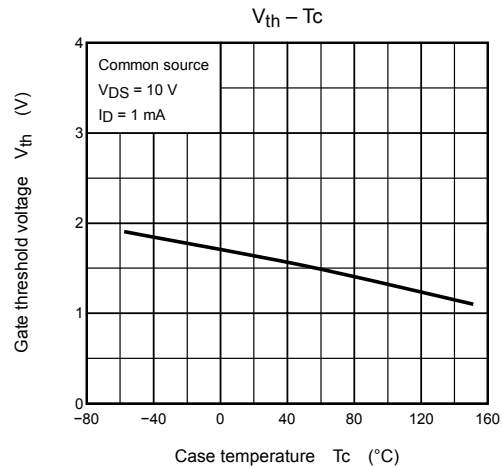
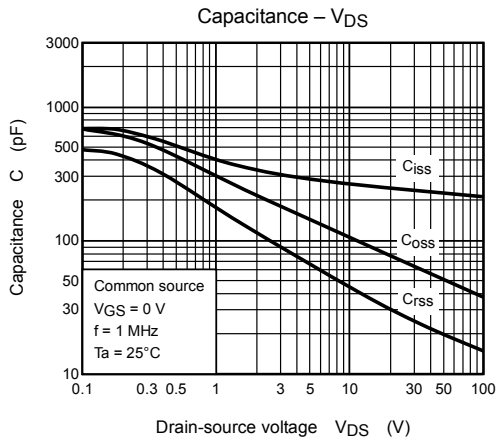
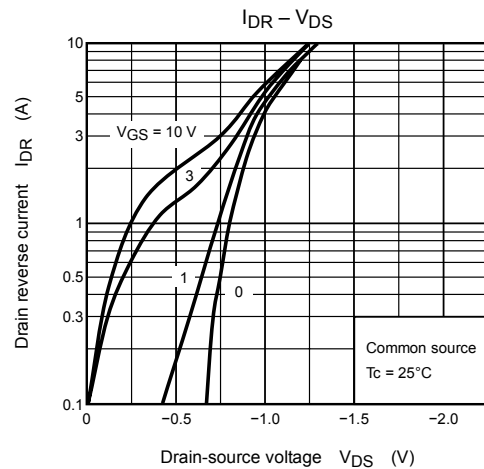
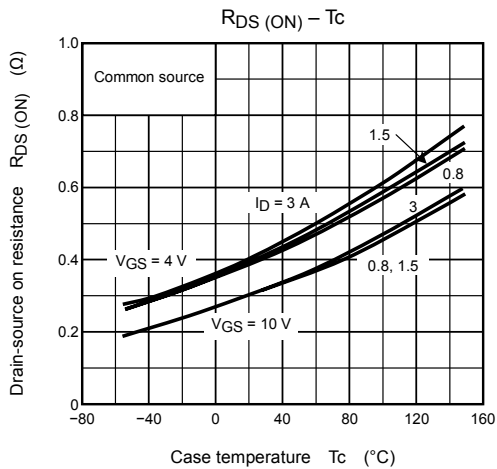
| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|----------------------------------|-----------|---|-----|------|------|---------------|
| Continuous drain reverse current | I_{DR} | — | — | — | 3 | A |
| Pulse drain reverse current | I_{DRP} | — | — | — | 12 | A |
| Diode forward voltage | V_{DSF} | $I_{DR} = 3\text{ A}$, $V_{GS} = 0\text{ V}$ | — | — | -1.5 | V |
| Reverse recovery time | t_{rr} | $I_{DR} = 3\text{ A}$, $V_{GS} = 0\text{ V}$, $dI_{DR}/dt = 50\text{ A}/\mu\text{s}$ | — | 100 | — | ns |
| Reverse recovery charge | Q_{rr} | | — | 0.2 | — | μC |

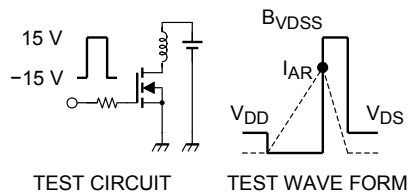
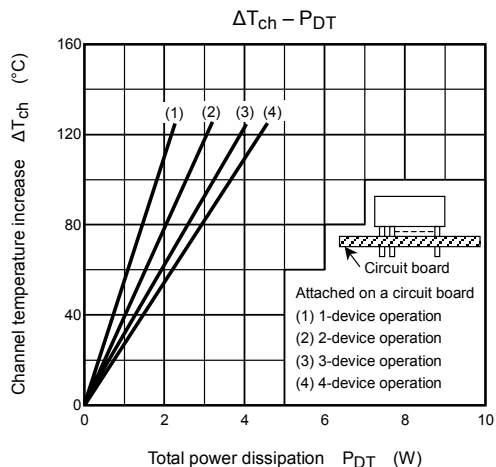
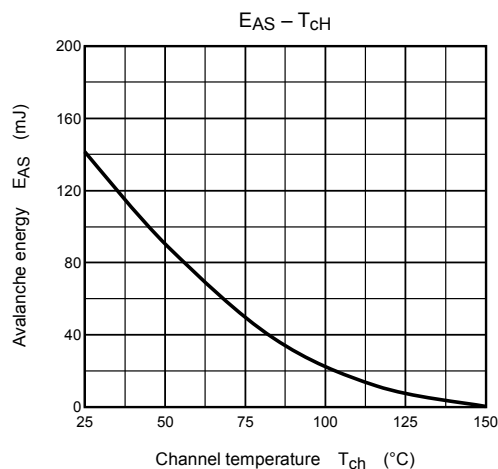
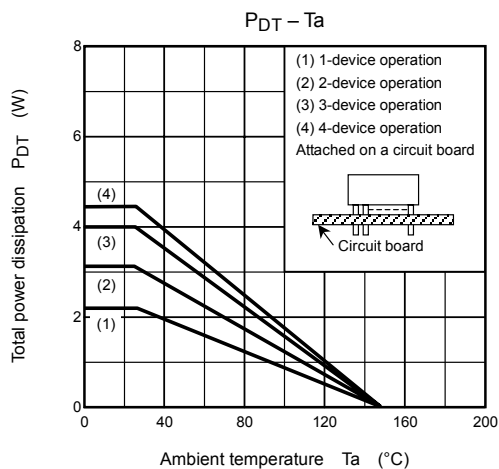
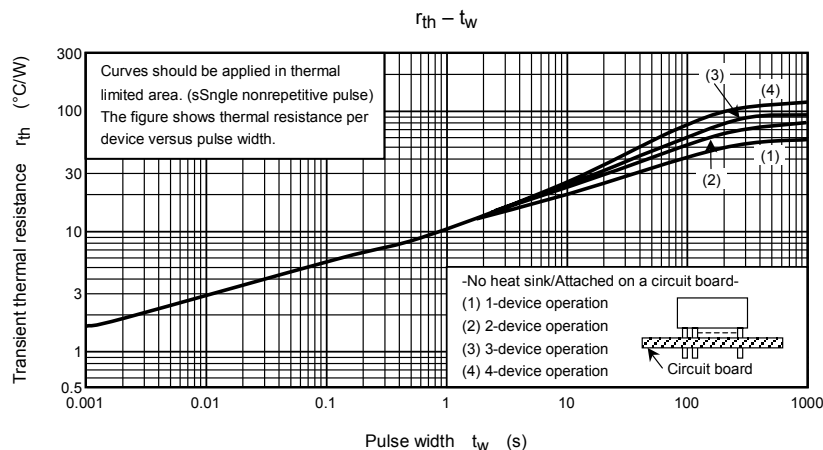
Flyback-Diode Rating and Characteristics (Ta = 25°C)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|-----------------|----------|--------------------------------|-----|------|-----|---------------|
| Forward current | I_{FM} | — | — | — | 3 | A |
| Reverse current | I_R | $V_R = 100\text{ V}$ | — | — | 0.4 | μA |
| Reverse voltage | V_R | $I_R = 100\text{ }\mu\text{A}$ | 100 | — | — | V |
| Forward voltage | V_F | $I_F = 0.5\text{ A}$ | — | — | 1.8 | V |

Marking







Peak $I_{AR} = 3\text{ A}$, $R_G = 25\ \Omega$
 $V_{DD} = 50\text{ V}$, $L = 20\text{ mH}$

$$E_{AS} = \frac{1}{2} L \cdot I_{AR}^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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